

Testing Requirements

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Testing Requirements



Criteria	Test Procedure	Sample Size	Testing Laboratory
Luminaire Efficacy	LM-79-2008	3	DOE approved 3 rd Party
Minimum Light Output	LM-79-2008	3	DOE approved 3 rd Party
Correlated Color Temperature (CCT)	LM-79-2008	3	DOE approved 3 rd Party
Color Rendering Index (CRI)	LM-79-2008	3	DOE approved 3 rd Party
Color Spatial Uniformity	LM-79-2008	3	Self-Certification
Color Maintenance	LM-79-2008	3	Self-Certification
Lumen Maintenance (L ₇₀)	LM-80-XX*		DOE approved Device Manufacturer
In situ Temperature Measurement Test	UL1598-2004	1	DOE approved 3 rd Party or UL Signatory

^{*} In development

Testing Requirements (cont.)



Criteria	Test Procedure	Sample Size	Testing Laboratory
In situ Temperature Measurement Test	UL1598-2004	1	DOE approved 3 rd Party or UL Signatory
Power Factor	ANSI C82.77-2002	3	DOE approved 3 rd Party
Noise		1	Self Certification
Flicker		1	Self Certification

 "DOE approved" 3rd Party Test Laboratories are currently listed at:

www.netl.doe.gov/ssl/CALiPER-FAQs.htm

DOE is actively soliciting additional laboratories

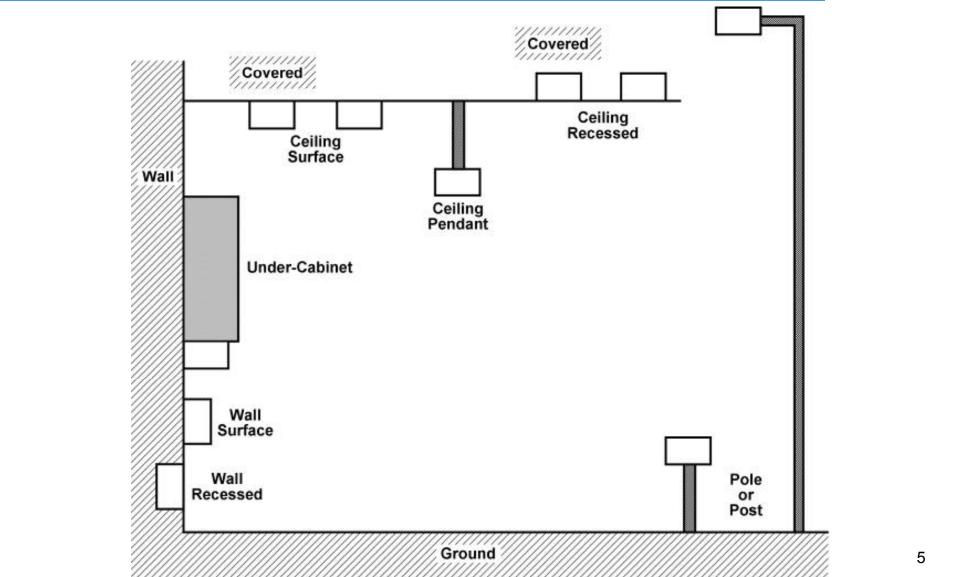
In Situ Testing Requirement



- Lumen depreciation (Life) determined by in situ temperature measurements of:
 - Module, Array or Light Engine
 - Power Supply/Driver
- Testing may be conducted at the same time as UL 1598.
- Testing conducted by independent third-party laboratory
- DOE will publish the In situ Temperature Measurement Test Procedure in June.

UL 1598 Environments





General Procedure



- Affix thermocouple to hottest LED device/array in the luminaire (designated by the luminaire manufacturer)
- Affix thermocouple to T_c or T_b Power Supply/Driver (designated by supplier)
- Install luminaire in UL 1598 Test Apparatus
- Allow system to reach thermal equilibrium
- Take readings and compare to LM-80 test data for device and power supply manufacturer warranty

Thermal Equilibrium

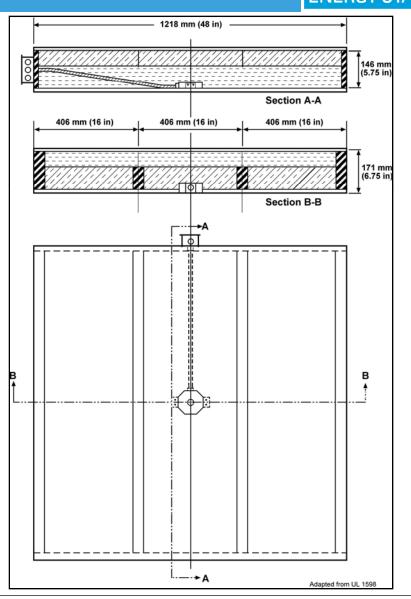


- Operate the luminaire in the appropriate UL 1598 Apparatus for:
 - A minimum of 7.5 hours; or
 - The test has been running for a minimum of 3 hours; and
 - 3 successive readings that at 15 min. intervals are with 1°C and are not rising

Surface Ceiling Temperature Test Apparatus



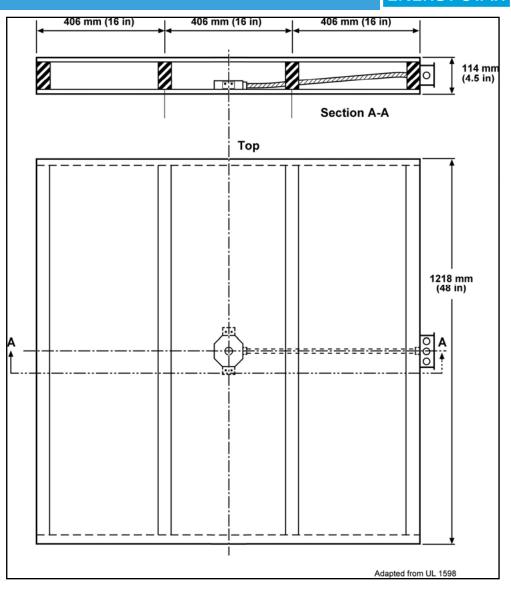
- ½" plywood
- 2 x 6 sides
- 1 x 6 ends
- 2 x 4 inside supports
- ≥ 72" above floor
- ≥ 12" below ceiling
- 2 layers of R-8/11 fiberglass insulation



Surface Wall Temperature Test Apparatus



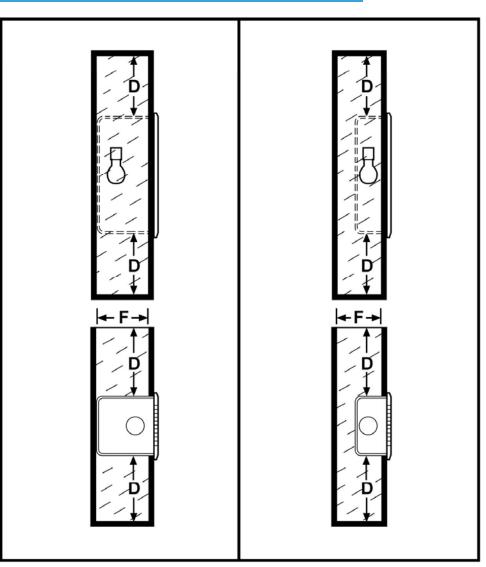
- ½" plywood
- 2 x 4 supports
- 1 x 4 ends
- ≥ 36" above floor
- ≥ 12" below ceiling
- 1 x 4 in horizontal position



Type Non-IC Recessed Wall Temperature Test Apparatus



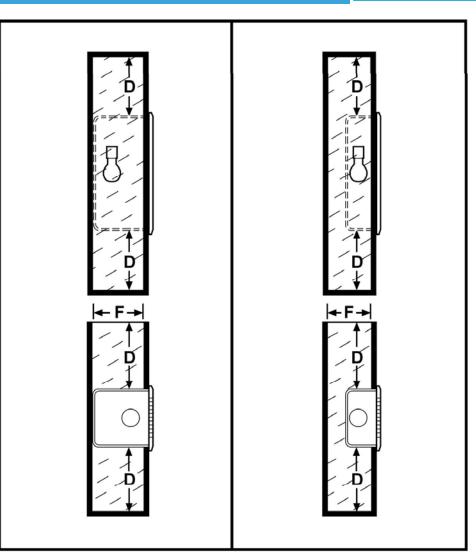
- ½" plywood
 "box"
- D ≥ 8.5"
- F = 6" or depth of luminaire



Type IC Recessed Wall-mounted Temperature Test Apparatus



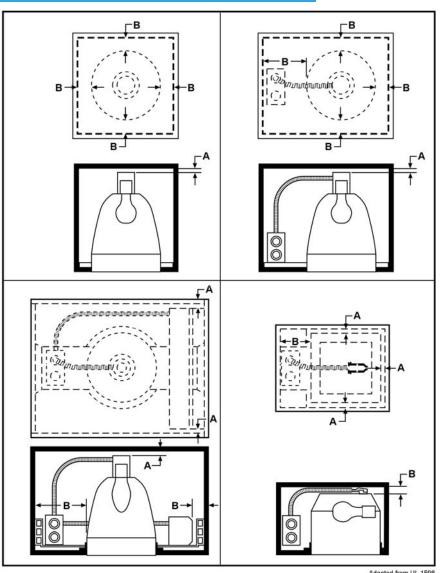
- ½" plywood "box"
- D ≥ 8.5"
- F = 6" or depth of luminaire
- Filled with Cellulose Insulation



Type Non-IC Recessed Ceiling-mounted Temperature Test Apparatus



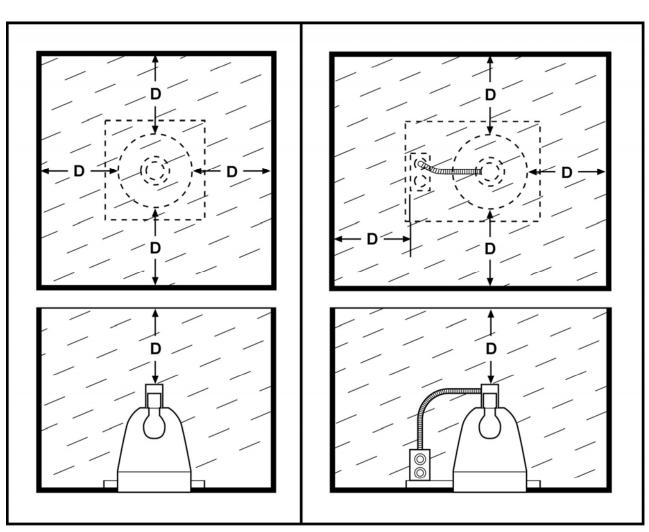
- ½" plywood "box"
- $A = \frac{1}{2}$ "
- $B > \frac{1}{2}$ "



Type IC Recessed Ceiling-mounted Temperature Test Apparatus



- ½"plywood"box"
- Open top
- D ≥ 8.5"
- Filled with Cellulose Insulation



Temperature Measurement Point (TMP)



- Manufacturer designated TMP correlating to LM-80 test report or power supply warranty
 - Module/Array
 - Solder Joint Temperature T_s
 - Case Temperature T_c
 - Board Temperature T_b
 - Power Supply
 - Case Temperature T_c
 - Could also be T_b for integral Power Supplies



Lumen Depreciation Qualification



- Option 1: Component Performance
 - Applicable if:
 - Module/Array has a current LM-80 test report
 - Module/Array has a designated TMP
 - TMP is accessible for in situ measurement
 - Otherwise manufacturer must use Option 2
- Option 2: Luminaire Performance
 - Entire luminaire subjected to LM-80

Lumen Depreciation Passing Criteria



A luminaire passes if the L_{70} threshold ($\geq 25,000$ hours for indoor residential and $\geq 35,000$ for all others) ...

 if the in situ measured drive current is the same or lower

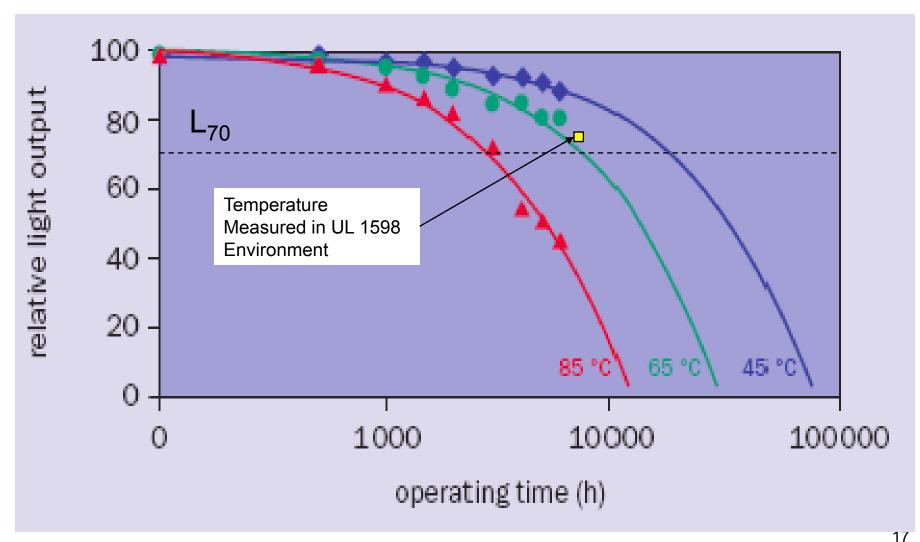
AND

 if the in situ measured TMP for the module/array is the same or lower

... than the LM-80 test report provided for the module/array.

Sample LM-80 Test Report





Questions?



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DOE SSL Website: www.netl.doe.gov/ssl/